Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/085,024	BACIK ET AL.
Examiner	Art Unit
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	SEARCHED				
Class	Subclass	Date	Examiner		
709	205 212 228	5/15/2005	JG		
370	400-402	5/15/2005	JG		
712	200-2001	5/15/2005	JG		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
PAM: Double Patenting Effective Filing Date	5/15/2005	JG
EAST: DERWENT EPO JPO USPAT	5/15/2005	JG
Internet : IEEE Google.com onelook.com NPLs	5/15/2005	JG
Primary Consulted: Frantz Jean: Statutory subject matter claim objection	5/15/2005	JG